

Vishay Siliconix

# P-Channel 20 V (D-S) MOSFET

PRODUCT SUMMARY						
V <sub>DS</sub> (V)	R <sub>DS(on)</sub> (Ω)	I <sub>D</sub> (A) <sup>e</sup>	Q <sub>g</sub> (TYP.)			
-20	$0.032$ at $V_{GS} = -4.5 \text{ V}$	-16				
	$0.046$ at $V_{GS} = -2.5 \text{ V}$	-14.3	14.5 nC			
	$0.065$ at $V_{GS} = -2.0 \text{ V}$	-12	14.5110			
	$0.120$ at $V_{GS} = -1.8 \text{ V}$	-2.5				

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Marking Code: xxxx = 8499

xxx = Date / lot traceability code

#### **Ordering Information:**

Si8499DB-T2-E1 (Lead (Pb)-free and halogen-free)

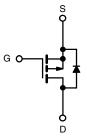
#### **FEATURES**

- TrenchFET® power MOSFET
- Ultra-small 1.5 mm x 1 mm maximum outline
- Ultra-thin 0.59 mm maximum height
- Material categorization: for definitions of compliance please see www.vishav.com/doc?99912



#### **APPLICATIONS**

- Low on-resistance load switch, charger switch and battery switch for portable devices
  - Low power consumption
  - Increased battery life



P-Channel MOSFET

<b>ABSOLUTE MAXIMUM RATINGS</b>	$T_A = 25  ^{\circ}C$ , unless	otherwise note	ed)		
PARAMETER	SYMBOL	LIMIT	UNIT		
Drain-Source Voltage	V <sub>DS</sub>	-20	V		
Gate-Source Voltage	V <sub>GS</sub>	± 12	V		
	T <sub>C</sub> = 25 °C		-16		
Continuous Proin Current (T 150 °C)	T <sub>C</sub> = 70 °C	, [	-13.7		
Continuous Drain Current (T <sub>J</sub> = 150 °C)	T <sub>A</sub> = 25 °C	I <sub>D</sub>	-7.8 <sup>a, b</sup>		
	T <sub>A</sub> = 70 °C		-6.3 <sup>a, b</sup>	Α	
Pulsed Drain Current		I <sub>DM</sub>	-20		
Continuous Courses Dunies Diode Coursest	T <sub>C</sub> = 25 °C		-10.8		
Continuous Source-Drain Diode Current	T <sub>A</sub> = 25 °C	I <sub>S</sub>	-2.3 <sup>a, b</sup>		
	T <sub>C</sub> = 25 °C		13		
Maximum Dowar Dissination	T <sub>C</sub> = 70 °C	ь	8.4	W	
Maximum Power Dissipation	T <sub>A</sub> = 25 °C	P <sub>D</sub>	2.77 <sup>a, b</sup>	VV	
	T <sub>A</sub> = 70 °C		1.77 <sup>a, b</sup>		
Operating Junction and Storage Temperature R	T <sub>J</sub> , T <sub>stg</sub>	-55 to +150	°C		
Package Reflow Conditions <sup>c</sup>	IR/Convection	-	260	U	

THERMAL RESISTANCE RATINGS							
PARAMETER	SYMBOL	TYPICAL	MAXIMUM	UNIT			
Maximum Junction-to-Ambient a, f	R <sub>thJA</sub>	37	45	°C/W			
Maximum Junction-to-Case (Drain)	Steady State	$R_{thJC}$	7	9.5			

#### Notes

- a. Surface mounted on 1" x 1" FR4 board.
- b. t = 10 s.
- c. Refer to IPC/JEDEC® (J-STD-020), no manual or hand soldering.
- d. Case is defined as the top surface of the package.
- e. Based on  $T_C = 25$  °C.
- f. Maximum under steady state conditions is 85 °C/W.



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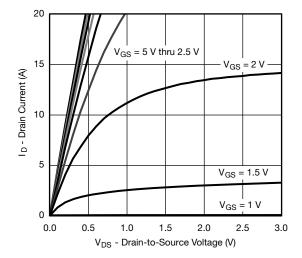
<b>SPECIFICATIONS</b> (T <sub>J</sub> = 25 °C, unless otherwise noted)								
PARAMETER	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNIT		
Static				1	l	I.		
Drain-Source Breakdown Voltage	$V_{DS}$	$V_{GS} = 0$ , $I_D = -250 \mu A$	-20	-	-	V		
V <sub>DS</sub> Temperature Coefficient	$\Delta V_{DS}/T_{J}$	J 050 A	-	-20	-	mV/°C		
V <sub>GS(th)</sub> Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	I <sub>D</sub> = -250 μA	-	2.2	-			
Gate-Source Threshold Voltage	V <sub>GS(th)</sub>	$V_{DS} = V_{GS}, I_{D} = -250 \mu A$	-0.5	-	-1.3	V		
Gate-Source Leakage	I <sub>GSS</sub>	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 12 \text{ V}$	-	-	± 100	nA		
7 0 1 1/1 5 1 0 1	1	V <sub>DS</sub> = -20 V, V <sub>GS</sub> = 0 V	-	-	-1	μA		
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>DS</sub> = -20 V, V <sub>GS</sub> = 0 V, T <sub>J</sub> = 70 °C	-	-	-10			
On-State Drain Current <sup>a</sup>	I <sub>D(on)</sub>	$V_{DS} \le -5 \text{ V}, V_{GS} = -4.5 \text{ V}$	-5	-	-	Α		
		V <sub>GS</sub> = -4.5 V, I <sub>D</sub> = -1.5 A	-	0.026	0.032			
Dunin Course On State Peristance 3	В	$V_{GS} = -2.5 \text{ V}, I_D = -1.5 \text{ A}$	-	0.036	0.046			
Drain-Source On-State Resistance a	R <sub>DS(on)</sub>	V <sub>GS</sub> = -2 V, I <sub>D</sub> = -1 A	-	0.048	0.065	Ω		
		V <sub>GS</sub> = -1.8 V, I <sub>D</sub> = -0.5 A	-	0.060	0.120			
Forward Transconductance <sup>a</sup>	9 <sub>fs</sub>	V <sub>DS</sub> = -10 V, I <sub>D</sub> = -1.5 A	-	10	-	S		
Dynamic <sup>b</sup>								
Input Capacitance	C <sub>iss</sub>		-	1300	-	pF		
Output Capacitance	C <sub>oss</sub>	V <sub>DS</sub> = -10 V, V <sub>GS</sub> = 0 V, f = 1 MHz	-	250	-			
Reverse Transfer Capacitance	C <sub>rss</sub>		-	200	-			
T. 10 1 0	Q <sub>g</sub>	V <sub>DS</sub> = -10 V, V <sub>GS</sub> = -5 V, I <sub>D</sub> = -1.5 A	-	20	30			
Total Gate Charge		V <sub>DS</sub> = -10 V, V <sub>GS</sub> = -4.5 V, I <sub>D</sub> = -1.5 A	-	14.5	22	nC		
Gate-Source Charge			-	2	-			
Gate-Drain Charge	Q <sub>gd</sub>		-	4.1	-			
Gate Resistance	$R_g$	V <sub>GS</sub> = -0.1 V, f = 1 MHz	-	7	-	Ω		
Turn-On Delay Time	t <sub>d(on)</sub>		-	20	40			
Rise Time	t <sub>r</sub>	$V_{DD}$ = -10 V, $R_L$ = 6.7 $\Omega$	-	25	50	ns		
Turn-Off Delay Time	t <sub>d(off)</sub>	$I_D \cong -1.5 \text{ A}, V_{GEN} = -4.5 \text{ V}, R_g = 1 \Omega$	-	50	100			
Fall Time	t <sub>f</sub>		-	30	60			
Turn-On Delay Time	t <sub>d(on)</sub>		-	7	15			
Rise Time	t <sub>r</sub>	$V_{DD}$ = -10 V, $R_L$ = 6.7 $\Omega$	-	10	20			
Turn-Off Delay Time	t <sub>d(off)</sub>	$I_D \cong$ -1.5 A, $V_{GEN}$ = -10 V, $R_g$ = 1 $\Omega$	-	55	110			
Fall Time	t <sub>f</sub>		-	30	60			
Drain-Source Body Diode Characteri	stics							
Continuous Source-Drain Diode Current	I <sub>S</sub>	T <sub>C</sub> = 25 °C	-	-	-10.8	А		
Pulse Diode Forward Current	I <sub>SM</sub>		-	=	-20			
Body Diode Voltage	$V_{SD}$	$I_S = -1.5 \text{ A}, V_{GS} = 0$	-	-0.8	-1.2	V		
Body Diode Reverse Recovery Time	t <sub>rr</sub>		-	40	80	ns		
Body Diode Reverse Recovery Charge	Q <sub>rr</sub>	 	-	22	45	nC		
Reverse Recovery Fall Time	t <sub>a</sub>	$I_F = -1.5 \text{ A, dI/dt} = 100 \text{ A/}\mu\text{s, T}_J = 25 ^{\circ}\text{C}$	-	15	-	ns		
Reverse Recovery Rise Time	t <sub>b</sub>	<b> </b>	-	25	-			

#### Notes

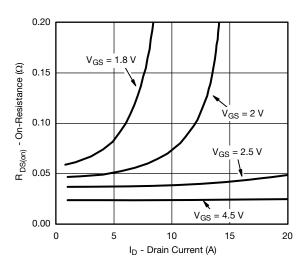
- a. Pulse test; pulse width  $\leq 300~\mu s,$  duty cycle  $\leq 2~\%.$
- b. Guaranteed by design, not subject to production testing.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

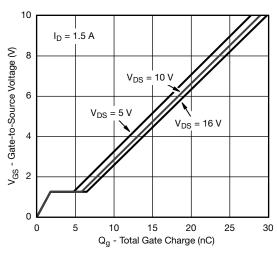




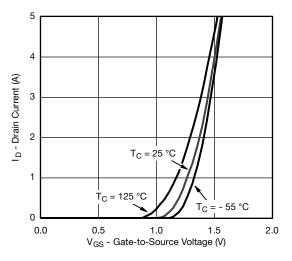
#### **Output Characteristics**



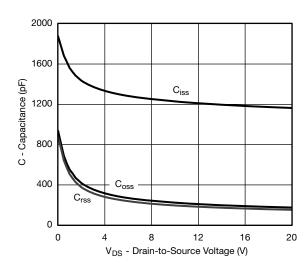
On-Resistance vs. Drain Current and Gate Voltage



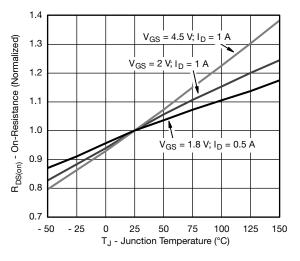
**Gate Charge** 



**Transfer Characteristics** 

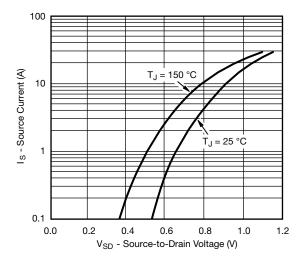


Capacitance

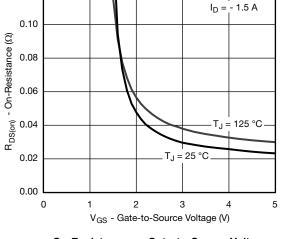


On-Resistance vs. Junction Temperature



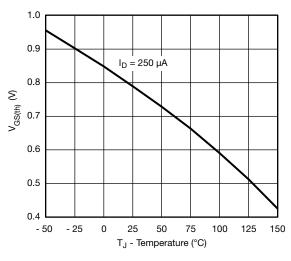


Source-Drain Diode Forward Voltage

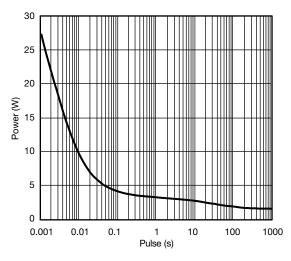


0.12

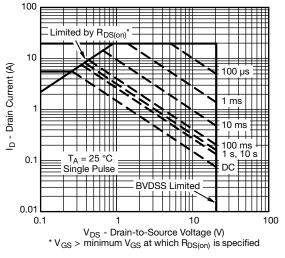
On-Resistance vs. Gate-to-Source Voltage



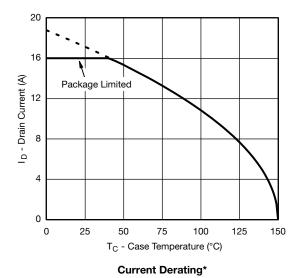
**Threshold Voltage** 

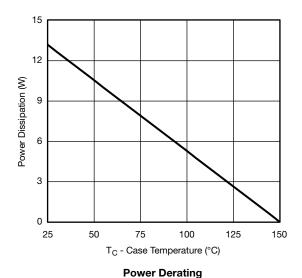


Single Pulse Power, Junction-to-Ambient



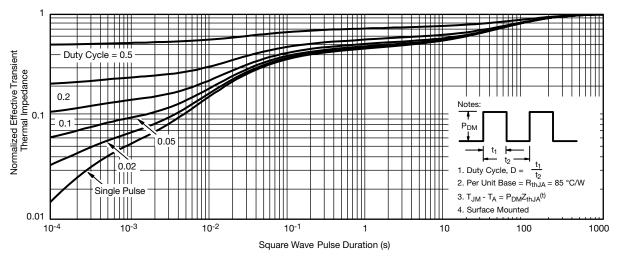




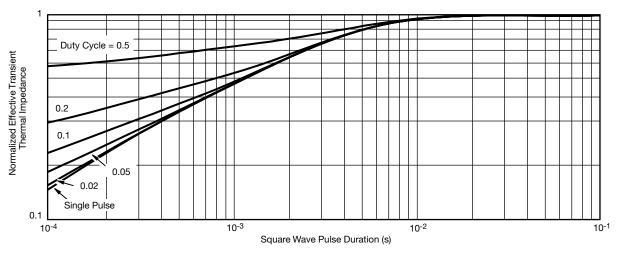


 $^{\star}$  The power dissipation P<sub>D</sub> is based on T<sub>J</sub> (max.) = 150 °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.





Normalized Thermal Transient Impedance, Junction-to-Ambient

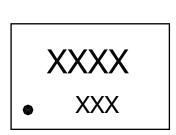


Normalized Thermal Transient Impedance, Junction-to-Case

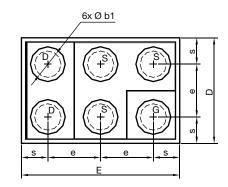
Vishay Siliconix maintains worldwide manufacturing capability. Products may be manufactured at one of several qualified locations. Reliability data for Silicon Technology and Package Reliability represent a composite of all qualified locations. For related documents such as package/tape drawings, part marking, and reliability data, see <a href="https://www.vishay.com/ppg?65906">www.vishay.com/ppg?65906</a>.

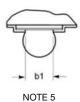
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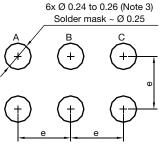
# MICRO FOOT®: 6-Bump (1.5 mm x 1 mm, 0.5 mm Pitch, 0.250 mm Bump Height)



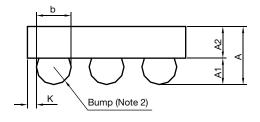
Mark on Backside of Die







Recommended Land Pattern



### Notes

(unless otherwise specified)

- 1. Six (6) solder bumps are 95.5/3.8/0.7 Sn/Ag/Cu.
- 2. Backside surface is coated with a Ti/Ni/Ag layer.
- 3. Non-solder mask defined copper landing pad.
- 4. Laser marks on the silicon die back.
- 5. "b1" is the diameter of the solderable substrate surface, defined by an opening in the solder resist layer solder mask defined.
- 6. is the location of pin 1

DIM.	MILLIMETERS			INCHES			
	MIN.	NOM.	MAX.	MIN.	NOM.	MAX.	
Α	0.510	0.575	0.590	0.0201	0.0226	0.0232	
A <sub>1</sub>	0.220	0.250	0.280	0.0087	0.0098	0.0110	
A <sub>2</sub>	0.290	0.300	0.310	0.0114	0.0118	0.0122	
b	0.297	0.330	0.363	0.0116	0.0129	0.0143	
b1	0.250			0.0098			
е	0.500			0.0197			
s	0.210	0.230	0.250	0.0082	0.0090	0.0098	
D	0.920	0.960	1.000	0.0362	0.0378	0.0394	
E	1.420	1.460	1.500	0.0559	0.0575	0.0591	
K	0.028	0.065	0.102	0.0011	0.0025	0.0040	

#### Note

Use millimeters as the primary measurement.

ECN: T15-0140-Rev. A, 20-Apr-15

DWG: 6035

Revison: 20-Apr-15 1 Document Number: 69426



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